

Application/Control No.	Applicant(s)/Patent unde Reexamination	r
10/520,880	FULFORD ET AL.	
Examiner	Art Unit	
Teiash D. Patel	3765	

SEARCHED				
Class	Subclass	<sup>.</sup> Date	Examiner	
2	455	8/28/2007	TP	
	465			
	228			
	267-268			
	79			
	463-467			
	16			
	44-45			
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
		141	-	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
PALM Searched	8/28/2007	TP		
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